3	arcn	Notes	

Application/Control N .	Applicant(s)/Patent under Reexamination
10/007,142	
Examiner	Art Unit
Erin M. File	2634

SEARCHED			
Class	Subclass	Date	Examiner
375	262	1/11/2005	EMF
370	339	1/12/2005	EMF
370	442	11/13/2005	· EMF

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	1/12/2005	EMF
PALM INVENTORSHIP	1/10/2005	EMF